

Notice of References Cited	Application/Control No. 10/816,820	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner DuyVu n. Deo	Art Unit 1765	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0211686	11-2003	Panda et al.	438/243
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NON-PATENT DOCUMENTS

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